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10/512016

DT01 Rec'd PCT/7 19 0CT 2004

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DEPOSIT INFORMATION

Express Mail Label No.: EV 327175278 US

Date of Deposit: October 19, 2004

Our Case No.: 10808/163

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

BARTH, Han-Joachim, et al.

Examiner: not assigned

Serial No.: not assigned

Group Art Unit No.: not assigned

Filing Date: October 19, 2004

For: METHOD FOR FABRICATING

THIN METAL-CONTAINING LAYERS HAVING LOW ELECTRICAL RESISTANCE

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents Alexandria, VA 22313-1450

Dear Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56, it is respectfully requested that this Information Disclosure Statement be entered and the documents listed below and on the attached Form PTO-1449 be considered by the Examiner and made of record. Copies of the listed documents required by 37 C.F.R. § 1.98(a)(2) are enclosed for the convenience of the Examiner.

The references now cited are the following:



U.S. PATENT DOCUMENTS

DOCUMENT NUMBER Number-Kind Code (if known)	DATE NAME		CLASS/ SUBCLASS	FILING DATE
3,585,088	6/15/1971	Schwuttke, et al.	148/174	10/18/1968
4,758,533	7/19/1988	Magee, et al.	437/173	9/22/1987
5,290,731	3/1/1994	Sugano, et al.	437/174	3/9/1992
5,405,804	4/11/1995	Yabe	437/773	1/21/1994
US 6,242,808 B1	6/5/2001	Shimizu, et al.	257/762	10/7/1998

FOREIGN PATENT DOCUMENTS

DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION YES OR NO
6/16/1987	EPO	H01L 21/20	No
6/26/1991	EPO	H01L 23/532	No
9/28/1992	Japan	H01L 21/3205	No
8/6/1999	Japan	H01L 21/3205	Yes
3/1/2000	EPO	H01L 21/768	No.

OTHER ART - NON PATENT LITERATURE DOCUMENTS

Jiang, Qing-Tang, Tsai, Ming-Hsing and Havemann, R.H., "Line Width Dependence of Copper Resistivity," Proceedings of the 2001 International Interconnect Technology Conf., page 227 (3 pages) International Search Report for counterpart international application number PCT/DE03/01205

(5 pages).

In accordance with 37 C.F.R. § 1.97(g),(h), this Information Disclosure Statement is not to be construed as a representation that a search has been made and is not to be construed to be an admission that the information cited is, or is considered to be, material to patentability as defined in 37 C.F.R. § 1.56(b).

This Information Disclosure Statement is being filed prior to the receipt of the first Official Action reflecting an examination on the merits and hence is believed to be timely filed in accordance with 37 C.F.R. § 1.97(b). No fees are believed to be due in connection with filing of this Information Disclosure Statement, however, should any fees under 37 C.F.R. §§ 1.16 to 1.21 be deemed necessary for any reason relating to these material, the Commissioner is hereby authorized to deduct said fees from Brinks

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Hofer Gilson & Lione Deposit Account No. 23-1925. A duplicate copy of this document is enclosed.

In accordance with 37 C.F.R. § 1.97(e)(1), Applicant(s) hereby certify that each item of the information disclosed in this Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to filing of the present statement, as evidenced by the date of the enclosed search report.

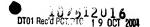
Applicant(s) respectfully request that the listed documents be made of record in the present case.

Respectfully submitted,

John G. Rauch

Registration No. 37,218 Attorney for Applicant(s)

BRINKS HOFER GILSON & LIONE P.O. Box 10395 Chicago, IL 60610 (312) 321-4200



FORM PTO-1449	SERIAL NO.	CASE NO.
	not assigned	10808/163
LIST OF PATENTS AND PUBLICATIONS FOR	FILING DATE	GROUP ART UNIT
APPLICANT'S INFORMATION DISCLOSURE	October 19, 2004	not assigned
STATEMENT		
(use several sheets if necessary)	APPLICANT(S): BARTH, Hans-	Joachim, et al.

DEEED	ENICE	DESIGNATION	

U.S. PATENT DOCUMENTS

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EXAMINER INITIAL		DOCUMENT NUMBER Number-Kind Code (If known)	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
/V.V./	A1	3,585,088	6/15/1971	Schwuttke, et al.	148/174	10/18/1968
	A2	4,758,533	7/19/1988	Magee, et al.	437/173	9/22/1987
	A3	5,290,731	3/1/1994	Sugano, et al.	437/174	3/9/1992
V	A4	5,405,804	4/11/1995	Yabe	437/773	1/21/1994
/V:V./	A5	US 6,242,808 B1	6/5/2001	Shimizu, et al.	257/762	10/7/1998
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7V.V./	A6	0 225 592 A2	6/16/1987	EPO	H01L 21/20	No
	A7	0 434 138 A1	6/26/1991	EPO	H01L 23/532	No
	A8	04271125 A	9/28/1992	Japan	H01L 21/3205	No
	A9	11214387 A	8/6/1999	Japan	H01L 21/3205	Yes
V	A10	0 982 771 B1	3/1/2000	EPO	H01L 21/768	No.
/V:V./						

EXAMINER INITIAL	(ii syn	OTHER ART – NON PATENT LITERATURE DOCUMENTS nclude name of autor, title of the article (when appropriate), title of the litem (book, magazine, journal, serial, nposium, catalog, etc.), date page(s), volume-issue number(s), publisher, city and/or country where published.
/V.V./	A11	Jiang, Qing-Tang, Tsai, Ming-Hsing and Havernann, R.H., "Line Width Dependence of Copper Resistivity," Proceedings of the 2001 International Interconnect Technology Conf., page 227 (3 pages)
	A12	International Search Report for counterpart international application number PGT/DE03/01205-

EXAMINER /Vanessa Velasquez/ DATE CONSIDERED 01/02/2008

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Rev. Dec.-99